

STTH61R04TV

Ultrafast recovery diode

Main product characteristics

I _{F(AV)}	2 x 30 A
V _{RRM}	400 V
Tj	150° C
V _{F (typ)}	0.95 V
t _{rr (typ)}	24 ns

Features and benefits

- Ultrafast
- Very low switching losses
- High frequency and high pulsed current operation
- Low leakage current
- Insulated package:
 - ISOTOP
 Electrical insulation = 2500 V_{RMS}
 Capacitance = 45 pF

Description

The STTH61R04TV series uses ST's new 400 V planar Pt doping technology. The STTH61R04 is specially suited for switching mode base drive and transistor circuits, such as welding equipment.



Order codes

Part Number	Marking
STTH61R04TV1	STTH61R04TV1
STTH61R04TV2	STTH61R04TV2

1 Characteristics

Table 1. Absolute ratings (limiting values per diode at 25° C, unless otherwise specified)

Symbol	I Parameter				Value	Unit
V _{RRM}	Repetitive peak reverse voltage	Repetitive peak reverse voltage			400	V
V _{RSM}	Non repetitive peak reverse voltage	Non repetitive peak reverse voltage			400	V
I _{F(RMS)}	RMS forward current			60	А	
I _{F(AV)}	Average forward current, $\delta = 0.5$	Per diode $T_c = 80^{\circ} C$		30	А	
I _{FRM}	Repetitive peak forward current	$t_p = 5 \ \mu s, F = 1 \ kHz \ square$			900	А
I _{FSM}	Surge non repetitive forward current $t_p = 10$ ms Sinusoidal			350	А	
T _{stg}	Storage temperature range			-65 to + 150	°C	
Тj	Maximum operating junction temperature			150	°C	

Table 2.Thermal parameters

Symbol	Parameter		Value	Unit
P	Junction to case	Per diode	1.5	
R _{th(j-c)}	Total	0.8	° C/W	
R _{th(c)}	Coupling thermal resistance		0.1	

When the diodes are used simultaneously:

 $\Delta T_{j(diode1)} = P_{(diode1)} \times R_{th(j-c)} (per diode) + P_{(diode2)} \times R_{th(c)}$

Table 3. Static electrical characteristics

Symbol	Parameter	Test conditions		Min.	Тур	Max.	Unit
I _R ⁽¹⁾	Reverse leakage current	$T_j = 25^\circ C$	V_ _ V			15	μA
'R`´	neverse leakage current	$T_j = 125^\circ C$ $V_R = V_{RRM}$			15	150	μΑ
		$T_j = 25^\circ C$				1.45	
V _F ⁽²⁾ Forward voltage drop	$T_j = 100^\circ C$	I _F = 30 A		1.05	1.3	V	
		T _j = 150° C			0.95	1.20	

1. Pulse test: $t_p = 5 \text{ ms}, \delta < 2 \%$

2. Pulse test: t_p = 380 µs, δ < 2 %

To evaluate the conduction losses use the following equation: P = 0.9 x $I_{F(AV)}$ + 0.01 x ${I_F}^2_{(RMS)}$



Table 4.	Dynamic	characteristics
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Symbol	Parameter	Test conditions	Min.	Тур	Max.	Unit
		$I_F = 1 \text{ A, } dI_F/dt = -50 \text{ A}/\mu\text{s},$ $V_R = 30 \text{ V, } T_j = 25^{\circ} \text{ C}$			65	
t _{rr}	Reverse recovery time	$ I_F = 1 \text{ A, } dI_F/dt = -100 \text{ A}/\mu\text{s}, \\ V_R = 30 \text{ V, } T_j = 25^\circ \text{ C} $		31	45	ns
	$ I_F = 1 \text{ A, } dI_F/dt = -200 \text{ A}/\mu\text{s}, \\ V_R = 30 \text{ V, } T_j = 25^\circ \text{ C} $		24	35		
I _{RM}	Reverse recovery current	$I_F = 30 \text{ A}, \text{ d}I_F/\text{d}t = -200 \text{ A}/\mu\text{s}, V_R = 320 \text{ V}, T_j = 125^{\circ} \text{ C}$		10	14	А
S	Softness factor	$I_F = 30 \text{ A}, \text{ d}I_F/\text{d}t = -200 \text{ A}/\mu\text{s}, V_R = 320 \text{ V}, T_j = 125^{\circ} \text{ C}$		0.4		
t _{fr}	Forward recovery time	$ I_F = 30 \ A \qquad dI_F/dt = 100 \ A/\mu s \\ V_{FR} = 1.5 \ x \ V_{Fmax}, \ T_j = 25^\circ \ C $		250		ns
V _{FP}	Forward recovery voltage	$I_F = 30 \text{ A}, \text{ d}I_F/\text{d}t = 100 \text{ A}/\mu\text{s},$ $T_j = 25^{\circ} \text{ C}$		2.9		V

Figure 1. Conduction losses versus average current









Figure 4. Pe ve

Peak reverse recovery current versus dl_F/dt (typical values)



1.0 Z_{bij-c}/R_{bij-c}) Single pulse ISOTOP

шù

1.E-02

tp(s)

1.E-01

1.E+00

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0.1

1.E-03

Figure 5. **Reverse recovery time versus** dl_F/dt (typical values) t_{RR}(ns) 160 150 I_F= 60A V_R=200V 140 130 120 110 100 ₽ T_j=125 °C 90 80 70 60 50 40 30 Tj=25 °C 20 10 dl_F/dt(A/µs) 0 10 100 1000

Figure 6. Reverse recovery charges versus dl_F/dt (typical values)



Figure 7. Relative variations of dynamic parameters versus junction temperature

Figure 8. Transient peak forward voltage versus dl_F/dt (typical values)



Figure 9. Forward recovery time versus dl_F/dt Figure 10. (typical values)

Junction capacitance versus reverse voltage applied (typical values)





2 Package information

Epoxy meets UL94, V0

Cooling method: by conduction (C)

Table 5. ISOTOP dimensions



In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

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3 Ordering information

Part Number	Marking	Package	Weight	Base qty	Delivery mode
STTH61R04TV1	STTH61R04TV1	ISOTOP	27 g	10	Tube
STTH61R04TV2	STTH61R04TV2	ISOTOP	27 g	10	Tube

4 Revision history

Date	Revision	Description of Changes
31-Mar-2007	1	First issue



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